

Search Notes

Application/Control No.

10/821,581

Examiner

Patricia Leith

Applicant(s)/Patent under
Reexamination

NAIR, MURALEEDHARAN G.

Art Unit

1655

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST:JPO,EPO,DERWENT,USPATF ULL,USPGPUBS,OCRBACKFILE	9/7/2007	PL
Inventor name search PALM/EAST	9/7/2007	PL
Reviewed all parent cases (reviewed what was on eDAN and previous rejections saved in my files)	9/7/2007	PL